Applicant(s)/Patent Under Application/Control No. Reexamination 10/692,736 HAYASE ET:AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2871 Toan Ton **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY 349/147 06-2005 Kaneko et al. US-6,912,035 Α 438/700 В US-2002/0016075 02-2002 Peng et al. C US-D US-Ε US-F US-G US-USн ı US-US-J Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS** Date **Document Number** Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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